

Applicant: Yuichi Akage et al.
Serial No.: 10/576,627
Filing Date: April 21, 2006
For: ELECTRODE PAD ON CONDUCTIVE SEMICONDUCTOR SUBSTRATE

Confirmation No.: 5766
Att'y Docket No.: 14321.83
Art Unit: 2873

INFORMATION DISCLOSURE CITATIONS MADE BY APPLICANTU.S. Patent Documents

| Examiner <u>Initial</u> * | Document <u>Number</u> | Issue <u>Date</u> | Name |
|------------------------------|---------------------------|----------------------|------|
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Foreign Patent Documents

| Examiner <u>Initial</u> * | Document <u>Number</u> | Publication <u>Date</u> | Country or <u>Patent Office</u> | Translation |
|------------------------------|---------------------------|----------------------------|------------------------------------|-------------|
| /RP/ 1 | 06-013438 | 01/21/1994 | Japan | No |
| /RP/ 2 | 2003-023010 | 01/24/2003 | Japan | No |

Other Documents

(including author, title, pertinent pages, etc.)

Examiner
Initial*

/RP/ 3 M.N. Khan et al., *Theoretical Prediction and Experimental Verification of Quantum Well Electroabsorption Modulators with Bandwidths Exceeding 40 GHz*, OFC99, paper ThT4-1/293.

Examiner: /Roy Potter/ (10/14/2008)

Date Considered: 10/14/2008

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References Cited by Applicants

While the filing of Information Disclosure Statements is voluntary, the procedure is governed by the guidelines of Section 609 of the Manual of Patent Examining Procedure and 37 C.F.R. §§ 1.97 and 1.98. To be considered a proper Information Disclosure Statement, Form PTO-1449 shall be accompanied by a copy of each listed patent or publication or other item of information and a translation of the pertinent portions of foreign documents (if an existing translation is readily available to the applicant), an explanation of relevance of each reference not in the English language, and should be submitted in a timely manner as set out in MPEP Sec. 609.

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The reference designations "A1," "A2," etc. (referring to Applicant's reference 1, Applicant's reference 2, etc.) will be used by the Examiner in the same manner as Examiner's reference designations "A," "B," "C," etc. on Office Action Form PTO-1142.

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Examiner: /Roy Potter/ (10/14/2008)

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